

<b>Notice of References Cited</b>	Application/Control No. 10/043,808	Applicant(s)/Patent Under Reexamination TEIG ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,262,487	07-2001	Igarashi et al.	257/758
	B	US-6,516,455	02-2003	Teig et al.	716/7
	C	US-6,645,842	11-2003	Igarashi et al.	438/598
	D	US-6,338,985	01-2002	Greenwood, Jonathon G.	438/126
	E	US-6,316,838	11-2001	Ozawa et al.	257/778
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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